nearly white, their O/P ratios are close to that of P_2O_3 (O/P ≤ 1.5) and they appear to react similarly.¹⁵ When they are deep yellow or orange-yellow, they are quite unreactive at room temperature.

When various finely divided reactive solids were spread across the surface of a small piece of ice cooled on Dry Ice, the solutions obtained by allowing this ice to melt were promptly analyzed by P31 n.m.r. It was found that P₄O₆ gave 100% orthophosphorous acid and "PO2" gave approximately 50% orthophosphorous and 50% phosphoric acids, of which about one-third was pyro- with the remainder being ortho-. The solutions resulting from reaction of the white and yellow precipitates all contained about three-quarters of the phosphorus as orthophosphorous acid. The precipitates formed by allowing P₄O₆ to react with PCl₃ or P(OCH₃)₃ showed the remainder of the soluble phosphorus to be orthophosphoric acid, with some (unreacted or precipitated) yellow material insoluble in water. As also found by Hossenlopp and Ebel,11 the amount of H₃PO₄ found after hydrolysis increased in parallel with the amount of unreactive yellow precipitate and with the yellowish coloration of the material prior to hydrolysis.

As noted above, continued heating of liquid P₄O₆ yields a yellow precipitate, which may be structurally

similar (but with P-O-P linkages) to amorphous red phosphorus, as envisaged by Pauling and Simonetta.16 Investigations17 of amorphous red phosphorus produced by heating white phorphorus in the presence of various catalysts have been interpreted to mean that the catalyst furnishes terminal groups to the network polymer made up of triply-connected phosphorus atoms. It is apparent from the work reported above that there is a continuous range of network polymers extending from nearly pure P₂O₃ to nearly pure phosphorus, with the color increasing from white through yellow, then orange, to red, as the phosphorus content increases. Presumably these polymers have highly complex structures involving P-P and P-O-P linkages as well as having some phosphorus atoms with unshared pairs of electrons and others of the phosphoryl variety. In addition, there are, of course, various structure-terminating groups, depending on the original composition and the thermal history. It is thought that the more reactive materials are those which have a predominance of P-O-P linkages and triply-connected phosphorus; i.e., the precipitates first formed from P₄O₆ exhibit a structure and reactivity most closely related to this starting material.

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Complexes of Xenon Oxide Tetrafluoride¹

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Received September 3, 1965

Xenon oxide tetrafluoride bears a strong resemblance to the halogen fluorides both in physical properties and chemical behavior. A number of physical properties of XeOF4 have been measured. Xenon oxide tetrafluoride is a clear, colorless liquid freezing at -46.2° . Its electrical conductivity at 24° is 1.03×10^{-6} ohm⁻¹ cm.⁻¹ and its dielectric constant is 24.6at 24°. It is miscible with anhydrous HF, but its conductivity is not enhanced in such a solution. The addition of CsF or RbF to XeOF4 increases its conductivity markedly. Xenon oxide tetrafluoride forms a series of addition compounds with the heavier alkali fluorides. The following complexes have been isolated: CsF·XeOF₄, 3RbF·2XeOF₄, and 3KF·XeOF₄. No reaction occurs with NaF. Thermogravimetric studies show that a number of intermediates are formed before final decomposition to the alkali fluorides. Xenon oxide tetrafluoride reacts with SbF₅ to form a complex of composition XeOF₄. $2SbF_{\delta}$. A reaction also occurs with AsF_{\delta} at -78° , but the complex is unstable at room temperature.

Introduction

Similarities between xenon fluorides and the halogen fluorides in their chemical bonding have been pointed out on a number of occasions. $^{2-4}$ It is to be expected that these analogies should be reflected in the chemical behavior of the xenon fluorides, and this has already been verified to some extent. It has been shown, for instance, that certain substances form complexes with xenon hexafluoride. Although it has not yet been unequivocally demonstrated, there are indications that these complexes are formed via acid-base type reactions and both basic salts⁵ and acid salts^{6,7} of xenon hexafluoride have been isolated. This similarity in chemi-

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⁽¹⁾ Based on work performed under the auspices of the U. S. Atomic Energy Commission.

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cal behavior of xenon hexafluoride to halogen fluorides apparently extends also to xenon oxide tetrafluoride. Indeed, it has been shown recently that bonding in this compound is remarkably similar to that in the series of compounds IF₅, BrF₅, ClF₅.⁸

In this paper, these analogies are extended further in an investigation of the chemical reactions of xenon oxide tetrafluoride with alkali fluorides and with antimony pentafluoride. These studies have resulted in the isolation of a series of complexes analogous to those obtained in the XeF_{θ} system.

Experimental Section

Materials.—Cesium and rubidium fluorides were prepared by repeated treatment of the hydroxides (obtained from A. D. Mackay, Inc., 99.0% minimum purity) with 48% HF and final dehydration and dehydrofluorination by heating to the melting point. The salts were subjected to chemical and spectrochemical analysis and showed only minor impurities (RbF: 0.2% K, 0.1% Si, 0.05% Cs; CsF: 0.2% K, 0.1% Si, 0.05% Rb). Potassium and sodium fluorides were ACS reagent grade materials. The alkali fluorides were additionally pretreated with HF-free fluorine before use.

Antimony pentafluoride was obtained from the Harshaw Chemical Co. and was purified by repeated vacuum sublimations in an all-Kel-F system until it assumed the high viscosity characteristic of pure SbF_5 . Xenon oxide tetrafluoride was prepared by partial hydrolysis of XeF_6 . Infrared spectra were obtained to attest to the absence of HF and the characteristic 520 cm. $^{-1}$ band of XeF_6 .

Melting Point.—The melting point of $XeOF_4$ was measured by the thermal-arrest method. Three-gram samples were condensed into a welded nickel tube, 1 cm. o.d. A concentric thermocouple well, 2 mm. o.d., extended nearly to the bottom of the tube so that the end of the thermocouple dipped at least 1 cm. into the surrounding compound. Temperatures were measured with a copper-constantan thermocouple which had been calibrated against an NBS platinum resistance thermometer. The sample had a marked tendency to supercool up to about 10° below the freezing point. Melting points of two separately prepared samples agreed within 0.2° .

Conductivity Measurements.—Measurements were carried out with a Model 216B Industrial Instruments Co. conductivity bridge. The cell and procedure were identical with ones described previously. ¹⁰

Dielectric Constant Measurements.—The dielectric constant of XeOF₄ was measured by the substitution method at 1 Mc. using a General Radio 716-CS1 Schering bridge, a 1214-M 1-Mc. oscillator, a 722-D Precision condenser, and a Tektronix 513-C oscilloscope as null detector. Interference of extraneous frequencies was minimized by also using the oscillator output as an external sweep. The dielectric constant cell was of all polychlorotrifluoroethylene (Kel-F) construction and the plates consisted of concentric Pt cylinders held rigidly in place with Teflon pins. The plate capacitance was 8.1 $\mu\mu$ f. The cell was calibrated by measuring its capacitance with purified samples of benzene, chlorobenzene, benzonitrile, and nitrobenzene.

Procedure.—Reactions were carried out in Kel-F containers sealed with Kel-F valves. The alkali fluorides were ground in a drybox and transferred to the empty preweighed container. After evacuation and pretreatment with fluorine, the tube was reweighed and the amount of material obtained by difference. A large excess of XeOF₄ was then distilled onto the salts and the

valve was closed. The mixture was then warmed intermittently to 50° and generally allowed to remain in contact overnight. The volume of solid increased markedly in the case of CsF and RbF and to a lesser extent with KF. The unreacted XeOF4 was then distilled off under reduced pressure until constant weight was obtained. The extent of conversion of the alkali fluoride to XeOF4 adduct was determined from the increase in weight of the starting material. On occasion, samples of the salt were dissolved in water in a Teflon bottle and aliquots were analyzed for xenon by iodometric titration.

Thermogravimetric analyses of the Cs, Rb, and K salts were run on a thermobalance previously described. 11

Results and Discussion

A number of the physical constants of XeOF₄ which are important in characterizing its solvent properties were measured. These are summarized in Table I.

Appearance	Clear, colorless liquid
Melting point, °C.	-46.2 to 0.2
Electrical conductivity, ohm ⁻¹ cm. ⁻¹	$1.03 imes 10^{-5}$ at 24°
Dielectric constant	$24.6~\mathrm{at}~24^\circ$
	28.0 at 0°
Density, g. cm. ⁻³	$3.11 \pm 0.03 \text{ at } 22.5^{\circ}$
Solubility in anhydrous HF	Miscible
Electrical conductivity in HF,	3×10^{-5} at 0° for $0.78~M$
ohm ^{−1} cm. ^{−1}	soln.

Two previous determinations of the melting point have been reported: $-28^{\circ 9}$ and $-41^{\circ}.^{12}$ These were obtained by visual observations of the melting point in quartz tubes. Xenon oxide tetrafluoride is known to react with quartz⁹; and, although the melting point is relatively low, this could account for discrepancies in previously reported values. The present value of -46.2° lies fairly close to one of these.

The extent of self-ionization in pure liquid XeOF4 is indicated by the electrical conductivity given in Table I. The two substances most likely to be present as impurities, HF and XeF₆, do not affect this result. The electrical conductivity of XeOF4 containing approximately 15% XeF₆ was essentially the same as that of pure XeOF₄. Moreover, the specific conductance of XeOF4 is changed only slightly by HF. However, solutions of CsF or RbF in XeOF4 increase markedly in conductivity. Cesium fluoride dissolves in XeOF4 to give a clear, colorless solution. A 0.29 M solution possessed a specific conductance of 8.5×10^{-3} ohm⁻¹ cm.⁻¹ at 24°. Rubidium fluoride is less soluble in XeOF4. Conductivity measurements made on a saturated solution of RbF in XeOF₄ yielded a specific conductance of 6.5×10^{-3} ohm⁻¹ cm.⁻¹ at 24° .

The dielectric constant of XeOF₄ lies between those of IF₅ and BrF₅.

Other properties of interest with respect to its value as a solvent are the density which is listed in Table I and the viscosity. No quantitative measurements were made of the viscosity, but qualitative observations show

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⁽¹¹⁾ C. E. Johnson and J. Fischer, J. Phys. Chem., 65, 1849 (1961).

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Starting matl.	Initial wt. of MF, g.	Final wt. of XeOF4, g.	Mole ratio		
CsF	0.0637	0.0890	1.05	Excess XeOF ₄ removed at 0°	
	$0.499 \\ 0.6275$	$0.753 \\ 0.9204$	0.97 1.00	moved at 0	
RbF	0.6177 1.0159 0.8645	0.9343 1.4824 1.1162	1.41 1.46 1.65	$ \begin{array}{ccc} Excess & XeOF_4 & removed & at room \\ temp. & Same & results at 0^\circ \end{array} $	
KF	0.0319 0.6031 0.6912	0.0420 0.7574 0.9030	2.90 3.06 2.95	Excess pumped off at room temp.	
NaF	$0.4186 \\ 0.5006$	0.0459 0.0186	50 144	No reaction. Possible small impurity	

it to be fairly mobile, although perhaps slightly more viscous than water.

The reactions of alkali fluorides with XeOF₄ are summarized in Table II. Although adducts are easily formed in the case of CsF, RbF, and KF, no NaF adduct was isolated at room temperature. The relative stabilities of the adducts appear to exhibit a trend similar to that observed with the XeF₆ adducts⁵ and that of the analogous alkali fluoride complexes of BrF₅ and ClF₃, ¹⁸ namely, CsF > RbF > KF.

Several samples of each adduct were subjected to thermogravimetric analyses, the results of which are shown in Figures 1 and 2. Although CsF·XeOF₄ loses XeOF₄ slowly at room temperature under vacuum, in a nitrogen stream at 1 atm. weight loss begins only at about 60°. The initial weight loss to 100° could be due to desorption of occluded XeOF₄. Two further inflection points are observed for which the weight loss indicates roughly the intermediate compounds noted in Figure 1. This may be summarized by the equations

$$CsF \cdot XeOF_4 \xrightarrow{\sim 125^{\circ}} 3CsF \cdot 2XeOF_4 \xrightarrow{\sim 275^{\circ}} 3CsF \cdot XeOF_4 \xrightarrow{\sim 400^{\circ}} CsF$$

It should be emphasized that these decomposition temperatures are strongly dependent on reaction conditions such as atmosphere above the sample and heating rate. The gas evolved in the first step is XeOF₄ as shown by infrared spectra. However, above 300° the evolved gas consists of mostly xenon, fluorine, and oxygen.

Thermogravimetric decomposition of the KF adduct shows that an intermediate is formed corresponding approximately to the stoichiometry 6KF·XeOF₄ (found 23.4% Xe, calculated 23.0% Xe). This may be summarized by the sequence

$$3KF \cdot XeOF_4 \xrightarrow{\sim 90^{\circ}} 6KF \cdot XeOF_4 \xrightarrow{\sim 250^{\circ}} KF$$

The final weight loss in all cases is somewhat less than that expected from the amount of starting material. This is due to slight attack on the nickel weighing pan at high temperatures as evidenced by a small

(13) E. D. Whitney, R. O. MacLaren, C. E. Fogle, and T. J. Hurley, J. Am. Chem. Soc., 86, 2583 (1964).

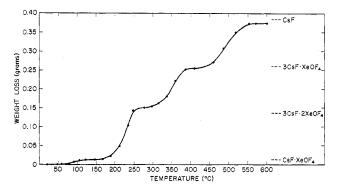


Figure 1.—Thermal decomposition of CsF·XeOF₄ in nitrogen flow of 200 cc./min. at 1 atm.; heating rate ~4°/min.

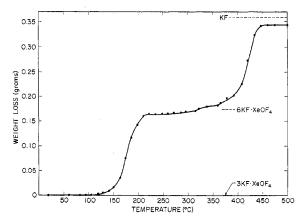


Figure 2.—Thermal decomposition of 3KF·XeOF₄ in nitrogen flow of 200 cc./min. at 1 atm.; heating rate ~2.5°/min.

purple deposit with strong oxidizing power, presumably M₂NiF₆ (M = Cs, Rb, K).¹⁴

In the case of the RbF adducts the situation is much less clear-cut. Thus far no consistent results have been obtained, and experiments had to be suspended because of limited access to the thermobalance. Two runs terminated in explosions of the samples. The RbF adduct isolated at room temperature has the approximate composition 3RbF·2XeOF₄. It begins to lose weight at about 50°, and the final decomposition occurs at about 400°. There is evidence for two intermediate compositions of as yet indeterminate stoichiometry.

A striking analogy thus exists in the stoichiometries of the RbF and KF adducts obtained at room temperature to those observed as intermediates in the decomposition of the CsF adduct. This analogy and the fact that NaF does not appear to form an adduct suggests that the size of the alkali cation plays an important role in the formation of these complexes.

All the alkali fluoride adducts are white solids which are nearly amorphous. It was not possible to obtain good X-ray powder photographs, and no lines due to the starting materials were observed. X-Ray analyses of the final decomposition products of all samples showed them to be alkali fluorides. Tests with KI showed that no oxidizing power was retained in the final product.

The XeOF₄ adducts are chemically very reactive and in bulk tend to react violently with water. No xenon

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Table III
Slow Hydrolysis of CsF·XeOF₄

Initial wt. of	Final wt.,	Final mol.
CsF·XeOF4, g.	g.	wt.
0.1734	0.1526	330.2
0.2928	0.2624	332.8

is evolved in either rapid or slow hydrolyses. When allowed to stand in air, samples of CsF·XeOF4 slowly evolved HF and eventually came to constant weight. Two such experiments are summarized in Table III. This suggests that the final composition corresponds to CsF·XeO₃ (calculated molecular weight 331.2). X-Ray powder photographs of this material are identical with those obtained from the slow hydrolysis of Cs-XeF₇. 15 No lines could be identified with CsF and XeO₃. A chemical analysis of one of the samples gave the following results: 40.9% Xe, 6.1% Fe, 39.4% Cs (calculated for CsF·XeO₃: 39.6% Xe, 5.7% F, 40.1% Cs). An infrared spectrum showed absorptions at 750 and 800 cm.⁻¹. These may possibly be identified with the ν_1 and ν_3 frequencies of XeO₃.² No absorptions were found in the Xe-F bond stretching region. Although both CsF and XeO3 are very hygroscopic, the CsF·XeO₃ product does not take up water. Moreover, in this case the CsF appears to have lost its normal tendency to absorb HF. These facts suggest that the hydrolysis product is not merely an equimolar mixture of CsF and XeO₃ but may consist of a loosely bound 1:1 molecular addition compound. CsF·XeO₃ decomposes explosively at about 160°.

As in the case of XeF₆, antimony pentafluoride forms a complex with XeOF₄. When XeOF₄ is warmed with an excess of SbF₅, a white precipitate is formed. After pumping off the excess SbF₅ to constant weight, the remaining solid has the composition XeOF₄·2SbF₅. Results of two experiments are given in Table IV. Chemical analysis of the second sample gave the following results: 39.0% F, 33.9% Sb (calculated for XeOF₄·2SbF₅: 40.5% F, 37.1% Sb). XeOF₄·2SbF₅ is a nonvolatile white solid melting at approximately 70°. In contact with excess SbF₅ it has a strong tend-

Table IV ${\bf Reaction~of~XeOF_4~with~Excess~SbF_5}$

Initial wt. of XeOF4, g.	Final wt. of SbF ₅ , g.	Mole ratio, SbF\$/XeOF4	Remarks
0.6928	1.3411	2.00	Reaction carried out in Ni vessel
0.6583	1.1506	1.80(1.97)	Reaction carried out in Kel-F. Small amt. of gas evolution. When corrected for Xe and O_2 SbF ₅ /XeOF ₄ = 1.97

ency to attack and rupture Kel-F. It reacts violently with water and organic materials.

Experiments with AsF₅ indicate that it forms an addition product with XeOF₄ at -78° . The adduct is unstable at room temperature. No reaction was observed between XeOF₄ and BF₃ up to 200°.

The foregoing results show that the chemistry of $XeOF_4$ bears a marked similarity to that observed with XeF_6 and the halogen fluorides. A number of halogen fluorides, notably BrF_3 and ClF_3 , have been shown to undergo self-ionization, and the existence of ionic salts of both acidic and basic types has been demonstrated. Analogs of these have been isolated in the XeF_6 and $XeOF_4$ systems.

Although the enhancement of conductivity of XeOF₄ by CsF and RbF points to a similar mechanism, it is possible that this merely reflects enhanced ionization and mobility of fluoride ion in a solvent of high dielectric constant. Conductometric titration studies would be desirable. These are difficult to carry out on a small scale. Unfortunately, large scale experiments are attended by the possibility of inadvertent leaks and the resulting formation of large amounts of the explosive XeO₃.

Acknowledgments.—The author wishes to thank M. Steindler of the ANL Chemical Engineering Division for use of the thermobalance and T. Gerding for extensive assistance in its manipulation. In addition the author is indebted to L. Quarterman of the Chemistry Division for the conductivity measurement on $XeOF_4$ in HF and to E. Sherry for X-ray analyses.

⁽¹⁵⁾ R. D. Peacock, H. Selig, and I. Sheft, to be published.